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A 1-D Imaging RIXS Spectrometer for Ultra-fast Phenomena and NonLinear Science at European XFEL

Joseph Nordgren

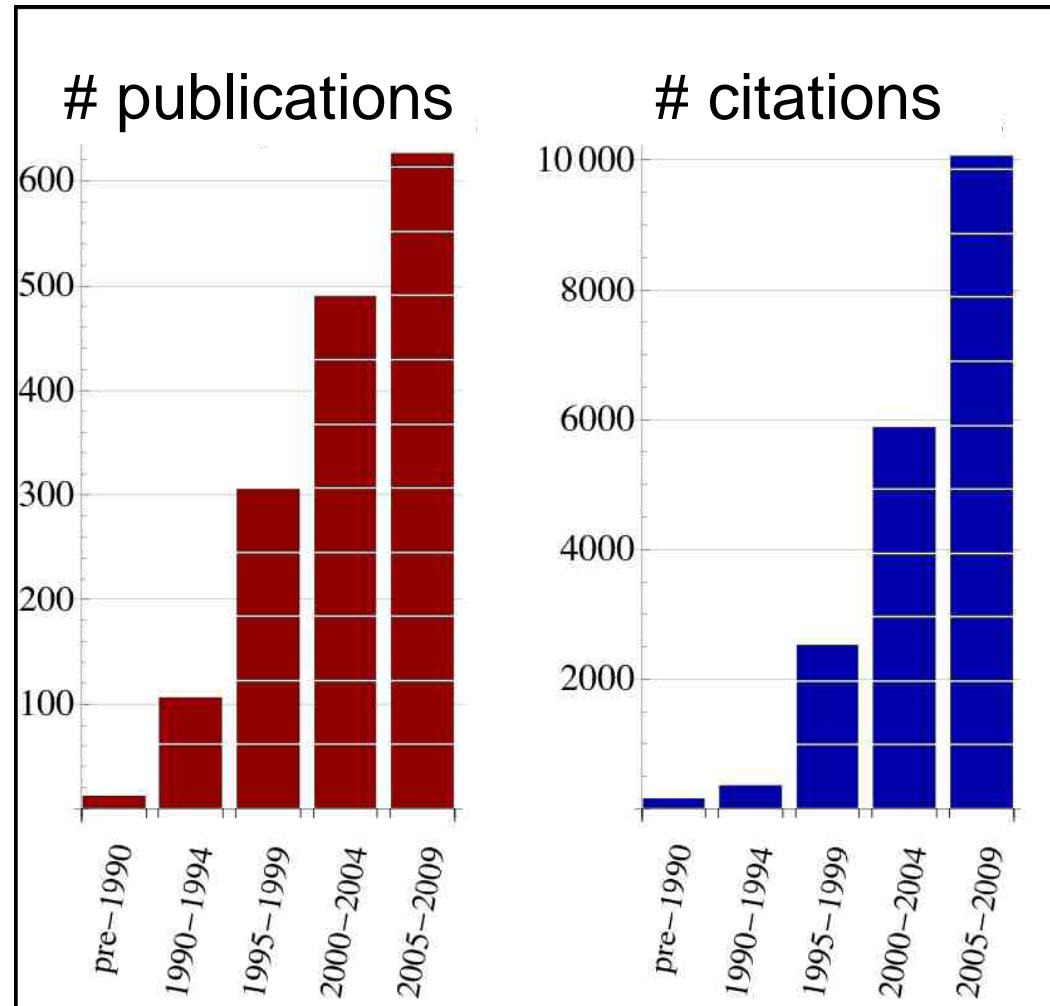
Dept. of Physics and Astronomy, Uppsala University, Sweden

Outline

- RIXS tutorial and scientific opportunities
- Experimental considerations
- The proposed instrument



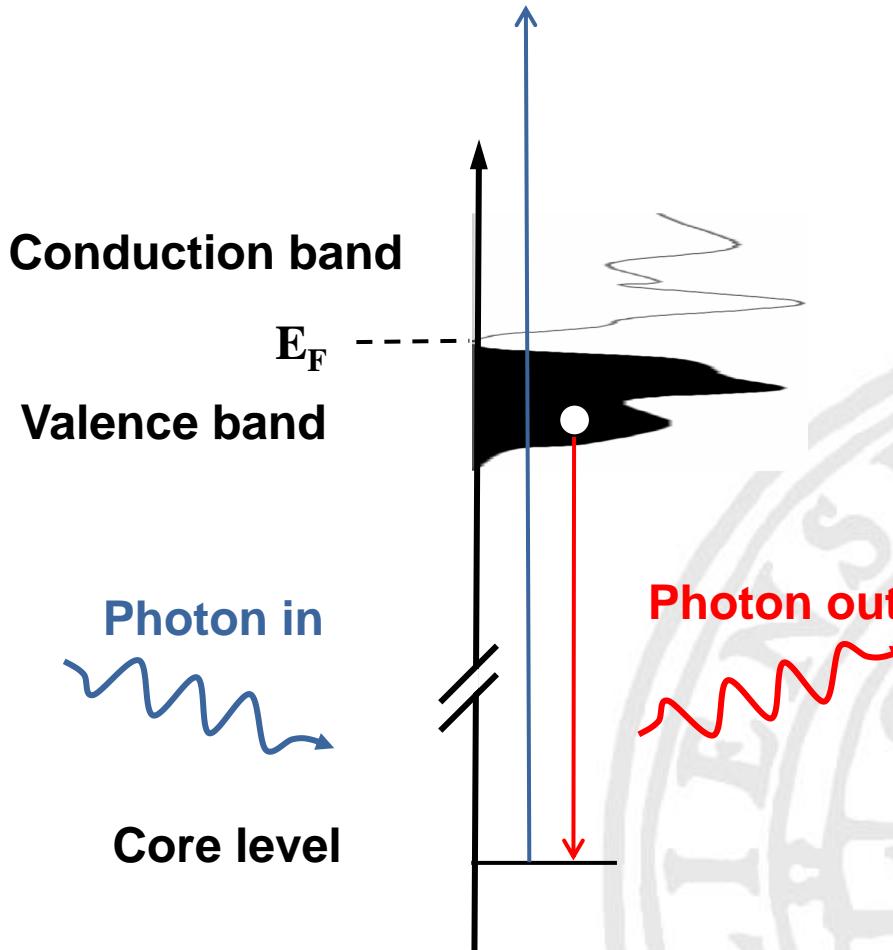
RIXS publication rates





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Valence-Core X-ray Spectroscopy

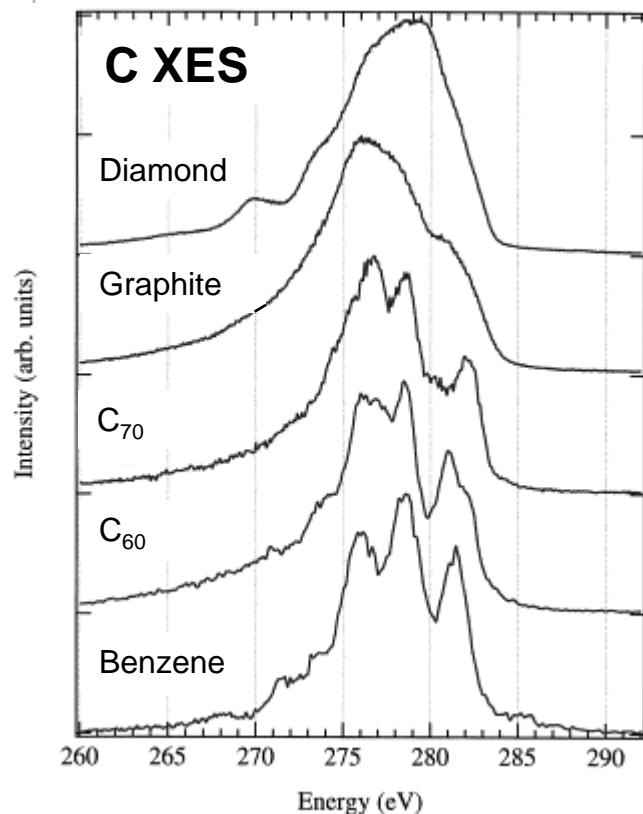




Examples

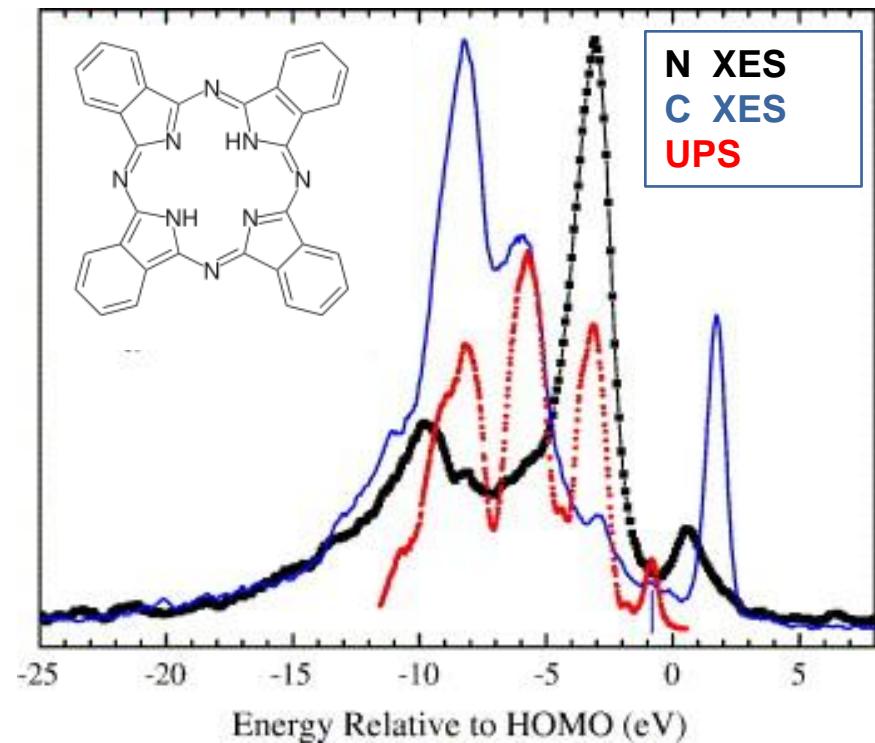
Valence-Core X-ray Emission

Carbon allotropes



J. Guo and J. Nordgren, *J. Electr. Spectr.*
110–111, 105–134 (2000)

Phthalocyanines

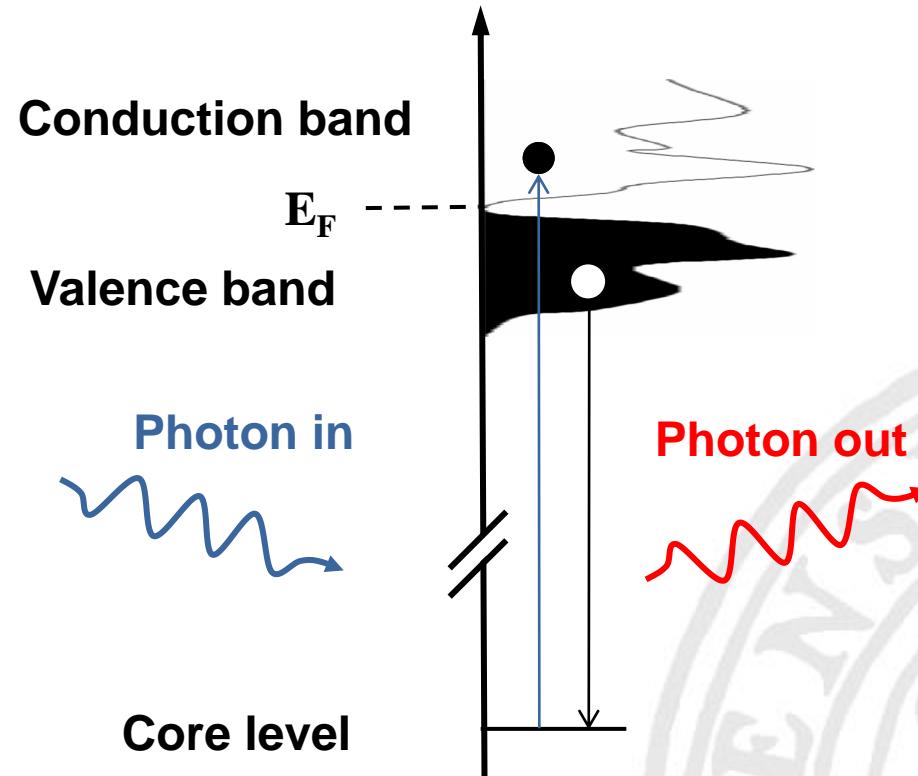


Y. Zhang et al., *Thin Solid Films*, 515,
394–400 (2006)



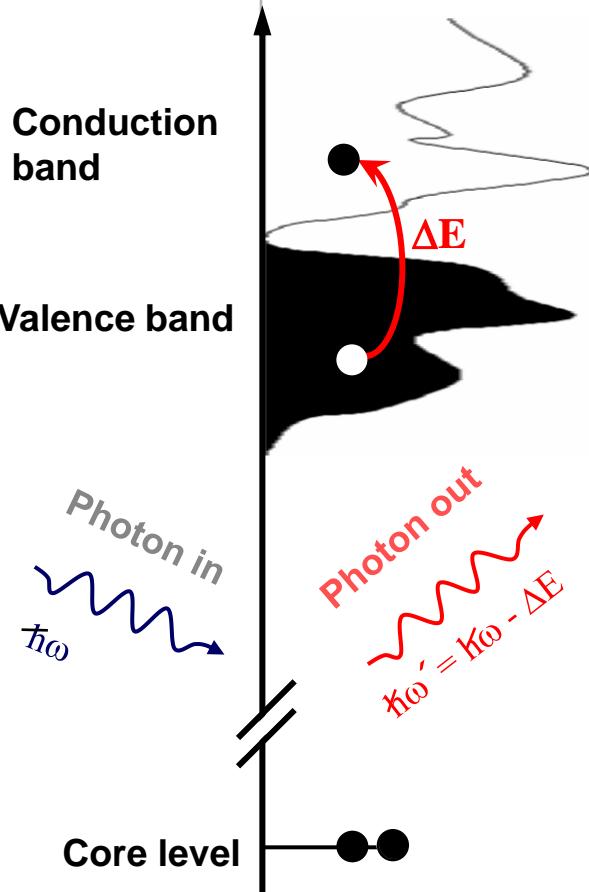
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Resonant X-ray emission





Resonant Inelastic X-ray Scattering (RIXS)



Inelastic scattering cross section
(Kramers-Heisenberg formula):

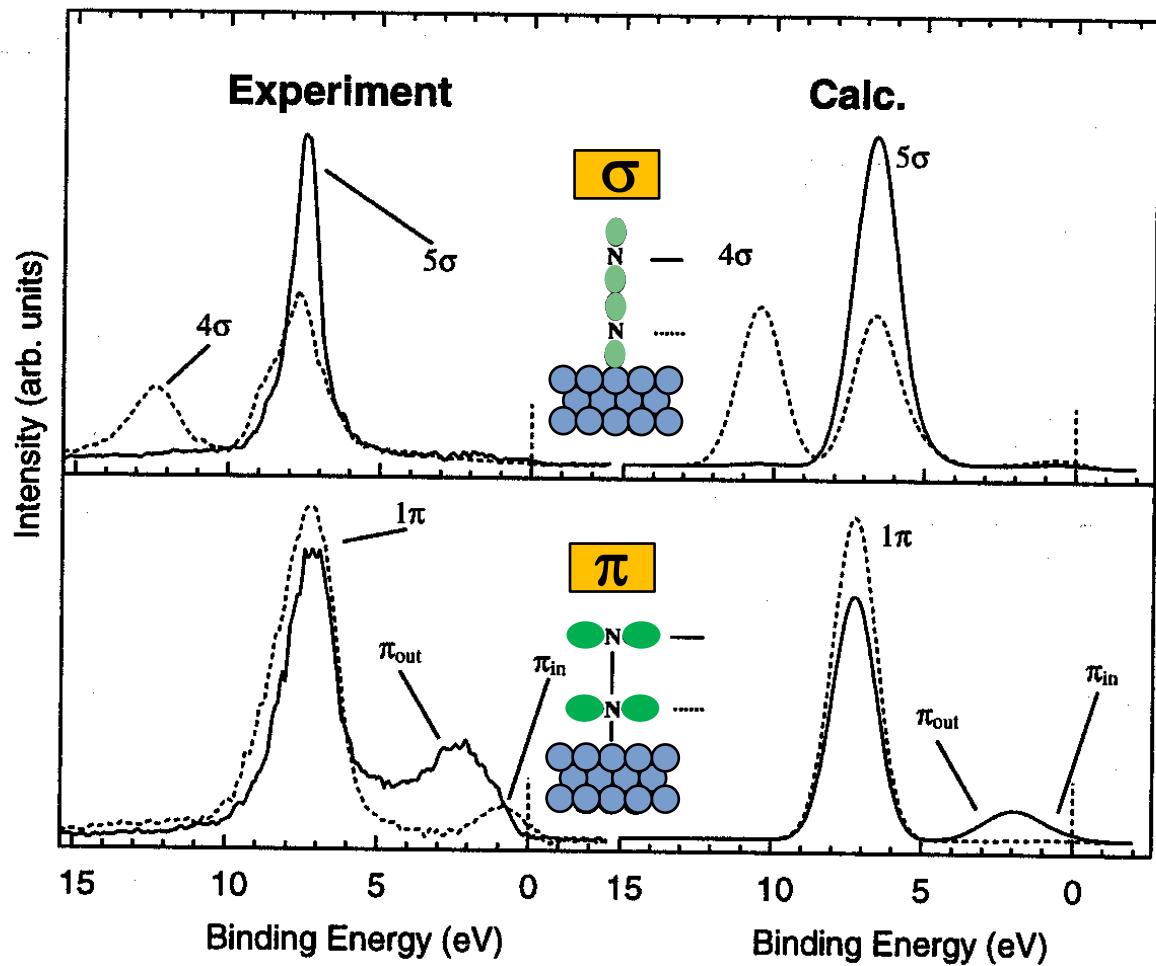
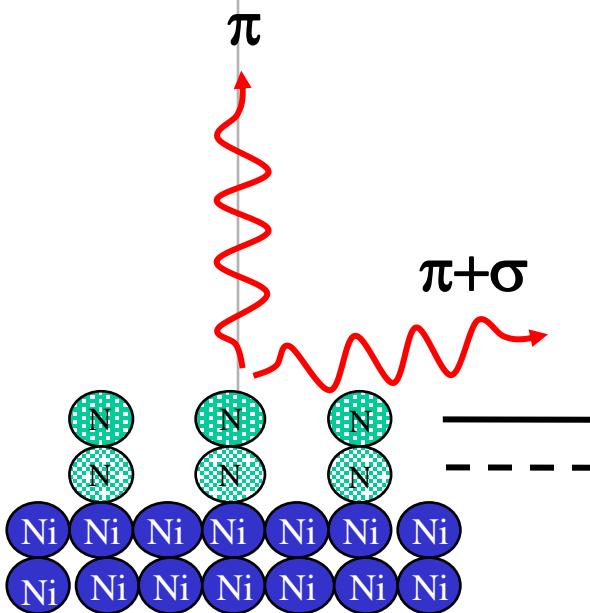
$$F(\omega, \omega') = \sum_f \left| \sum_m \frac{<f|D|m><m|D|g>}{E_g + \hbar\omega - E_m - i\Gamma_m} \right|^2 \delta(E_g + \hbar\omega - E_f - \hbar\omega')$$

Features of RIXS spectra:

- Site selectivity
- Symmetry selectivity
- Probing of low-energy excitations
- Sub-natural width spectra
- Ultra-fast dynamics
- Bulk and buried structures
- Band dispersion



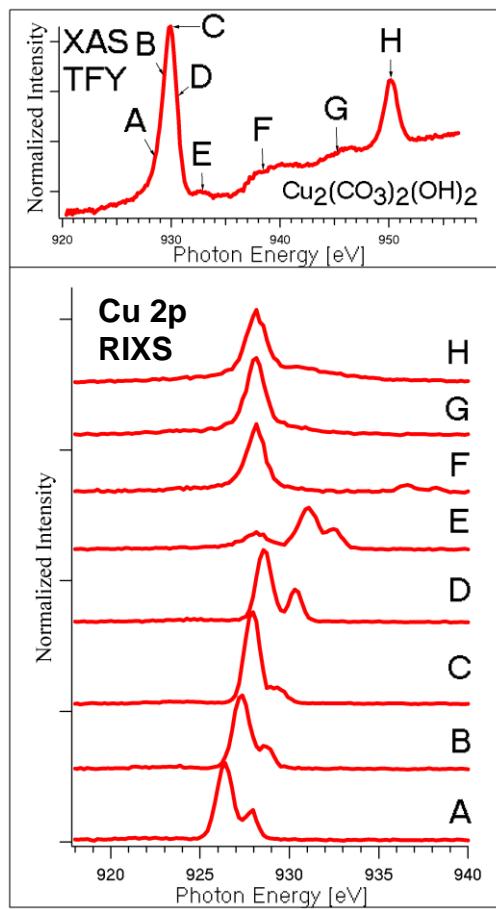
Site and Symmetry Selectivity in Resonant X-ray emission



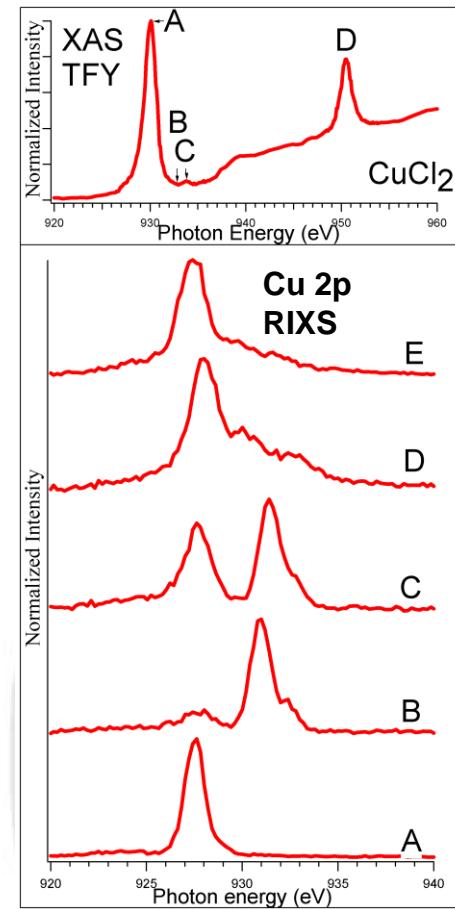


Analysis Capability of RIXS for Cu compounds

Malachite



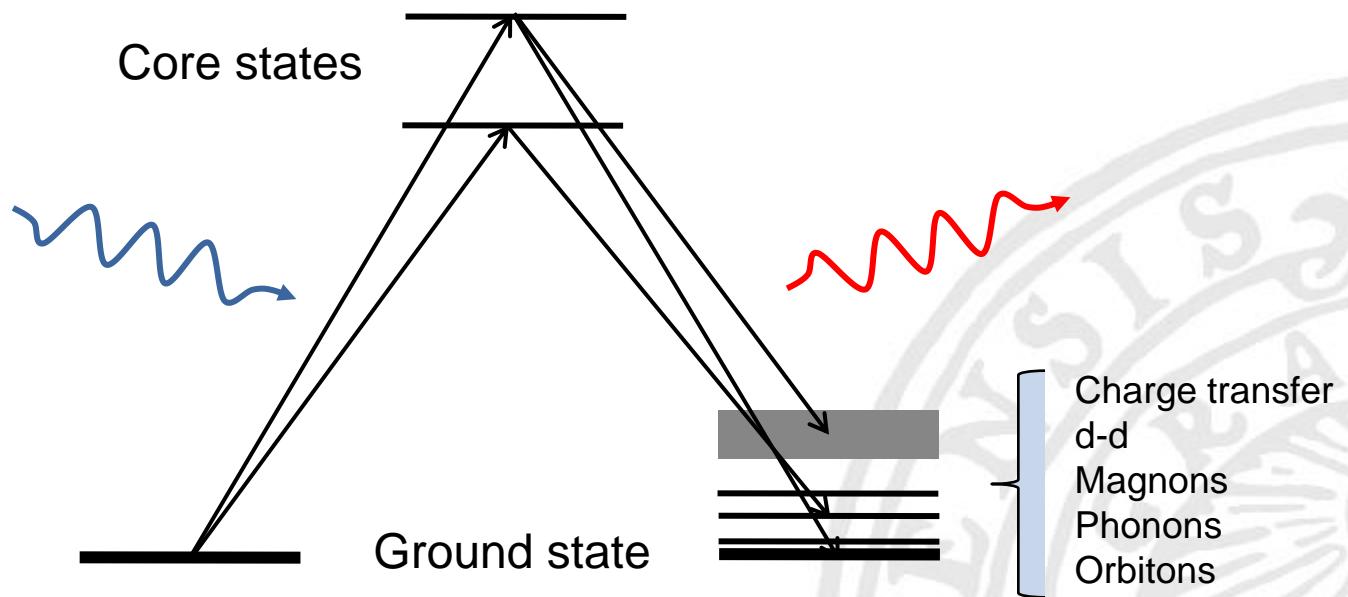
CuCl_2





Elementary Excitations in Strongly Correlated Materials

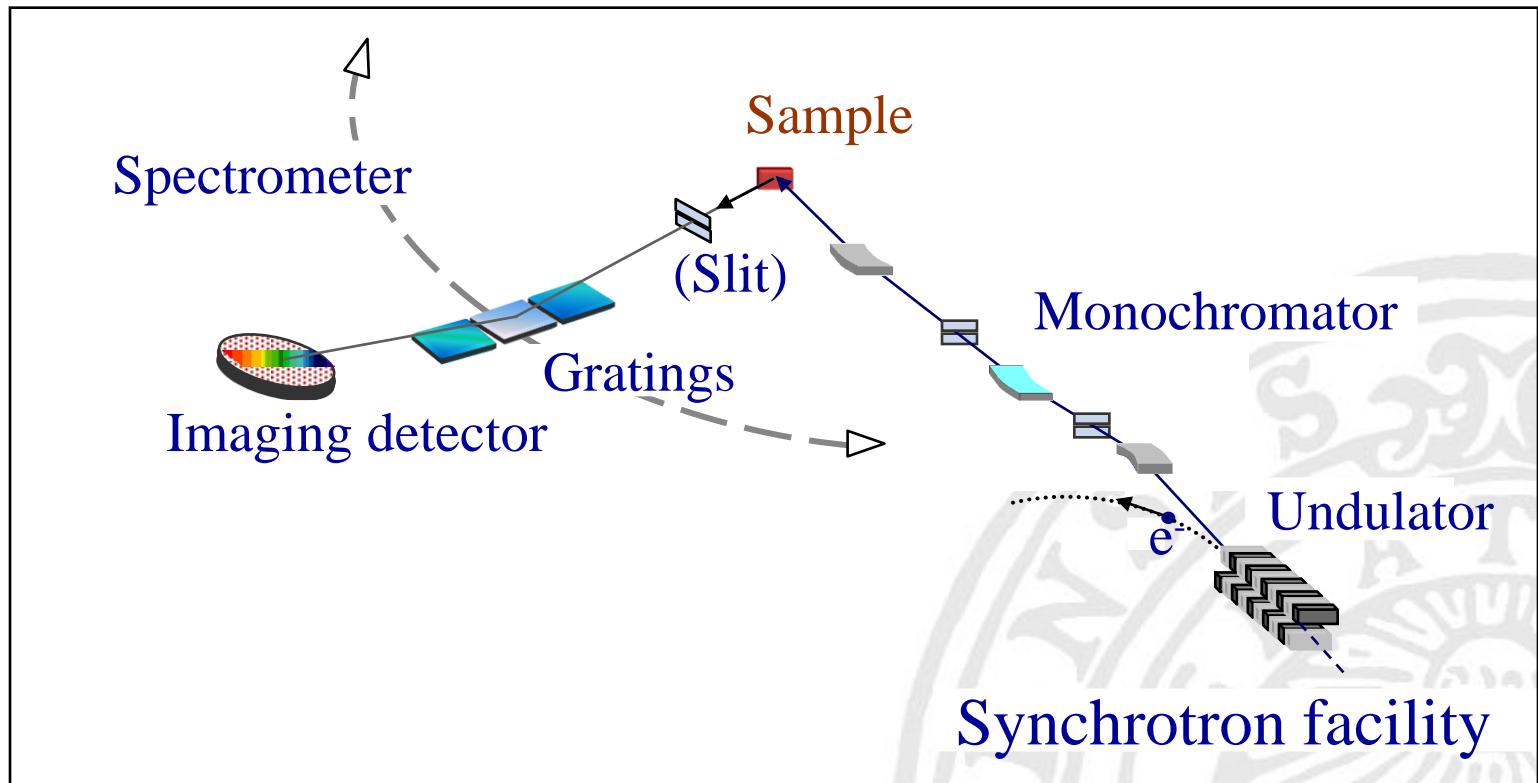
$$F(\omega, \omega') = \sum_f \left| \sum_m \frac{\langle f | D | m \rangle \langle m | D | g \rangle}{E_g + \hbar\omega - E_m - i\Gamma_m} \right|^2 \delta(E_g + \hbar\omega - E_f - \hbar\omega')$$

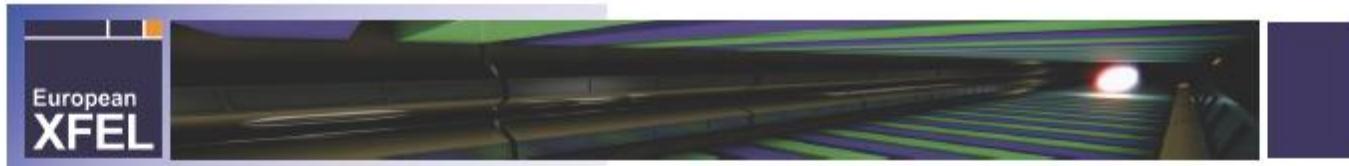


For original work, see e.g., S. Butorin, *et al.*, *Phys. Rev. Lett.*, **77**, 574 (1996)
For excellent review, see L.J.P. Ament, *et al.*, *Rev. Mod. Phys.*, **83**, No.2 (2011)



Experimental setup for RIXS

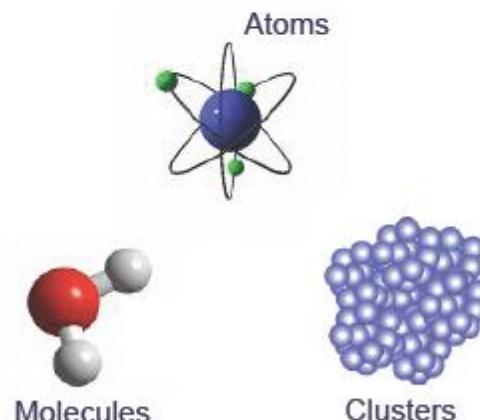




The SQS - Scientific Instrument at the European XFEL

M. Meyer, European XFEL GmbH

“Small Quantum
Systems”

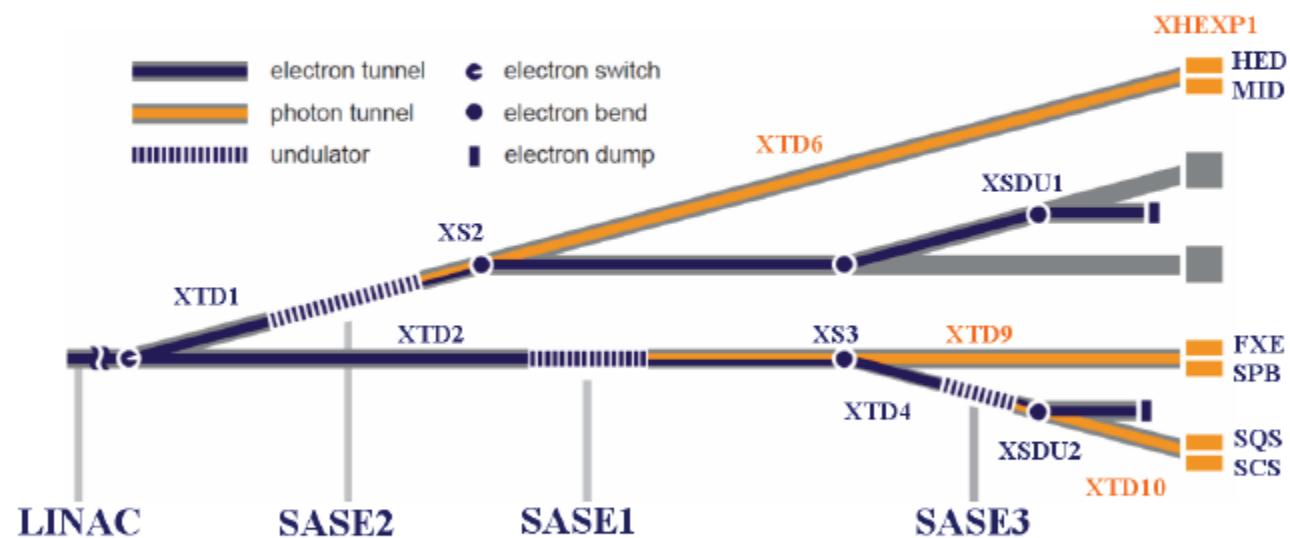




European XFEL

SQS Scientific Instrument

Photon beam transport systems

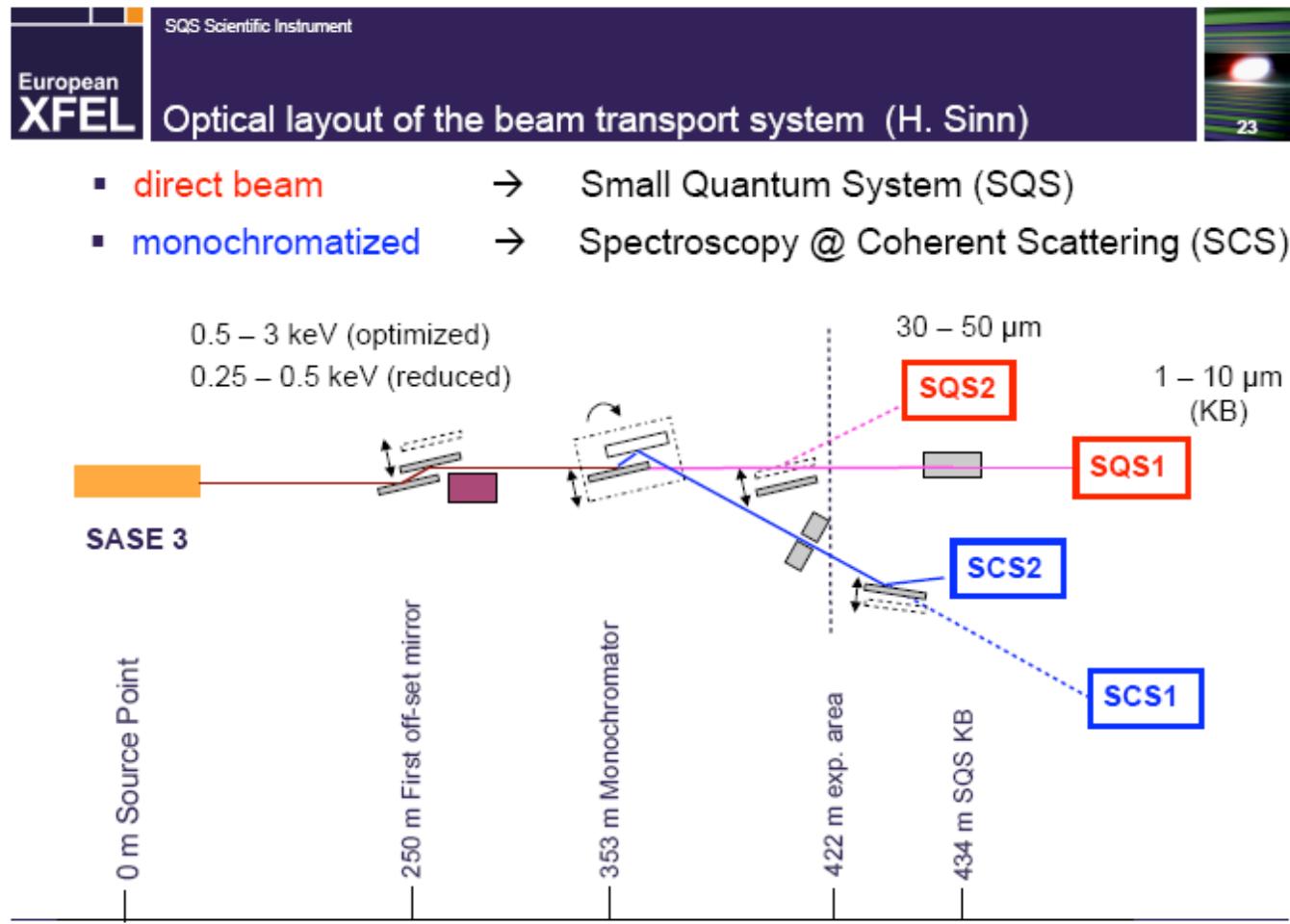




The banner features the European XFEL logo on the left and a small image of an X-ray diffraction pattern on the right. The text "SQS Scientific Instrument" is at the top left, and "Scientific Applications" is in the center.

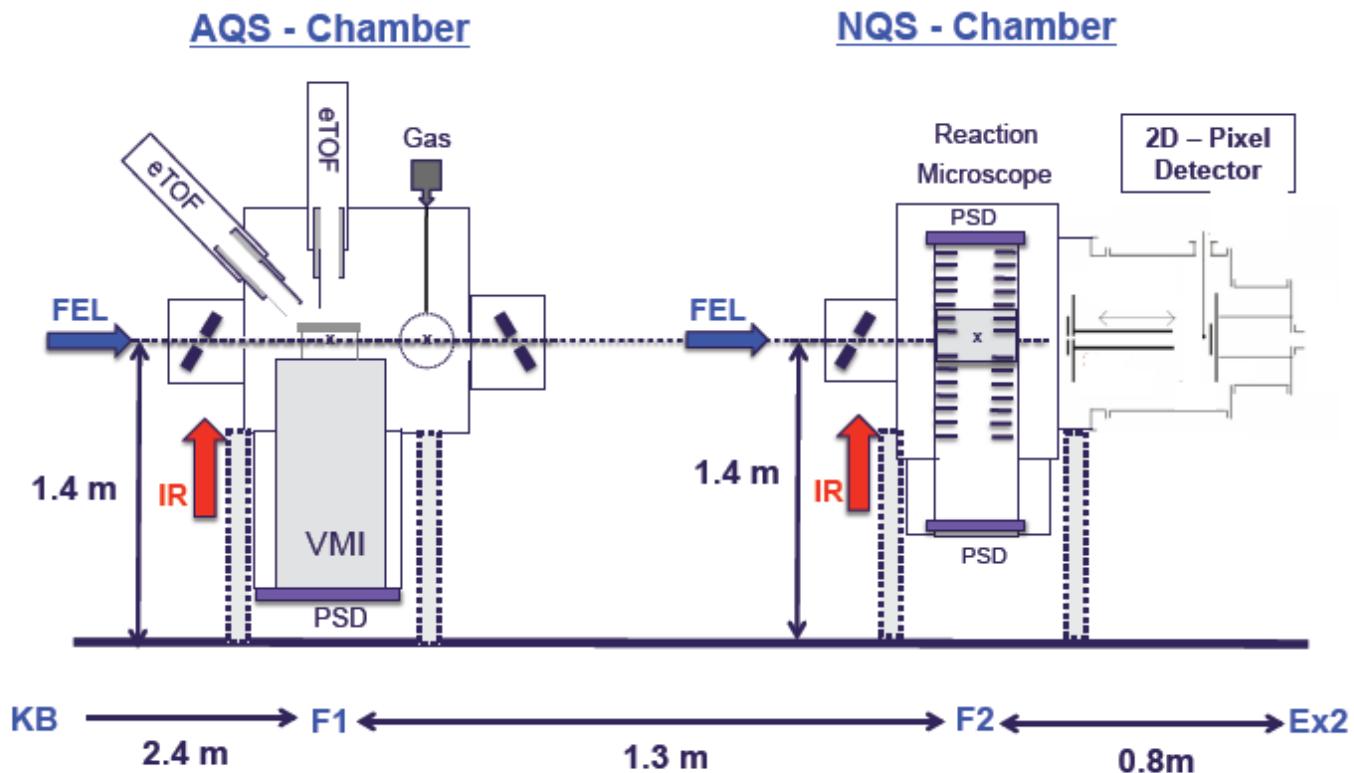
SQS – Small Quantum Systems – Investigation of atoms, ions, molecules and clusters in intense fields and non-linear phenomena

- High intensities:** $>10^{15} \text{ W/cm}^2$  **Non-linear phenomena, multi-photon**
- Short pulses:** 2 - 100 fs  **Ultra-fast dynamics, pump-probe**
- High flux** $> 10^{12} \text{ photons / pulse}$
 $> 10^{15} \text{ photons / sec}$  **Extremely dilute targets,
Processes with small cross section**
- Spatial coherence**  **Coherent Diffraction Imaging**
- Soft X-Ray photon energies**  **Threshold phenomena**
 $\text{C(1s)=290 eV, N(1s)=410eV, O(1s)=560eV}$



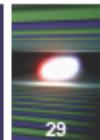


European XFEL SQS Scientific Instrument
SQS end-station



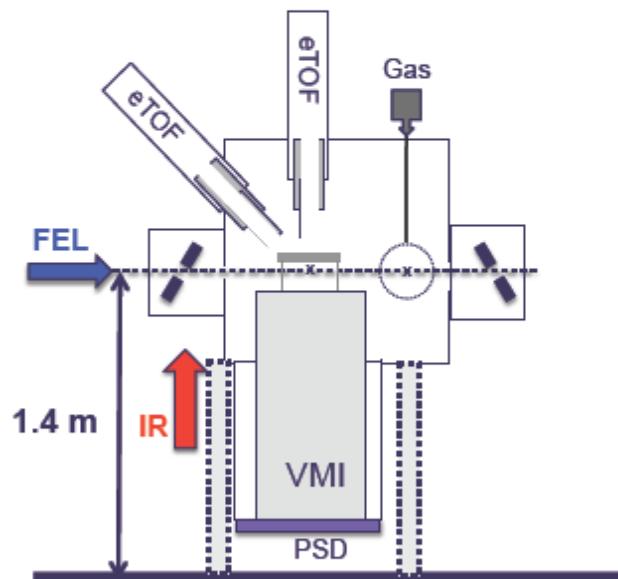


European XFEL SQS Scientific Instrument
SQS end-station

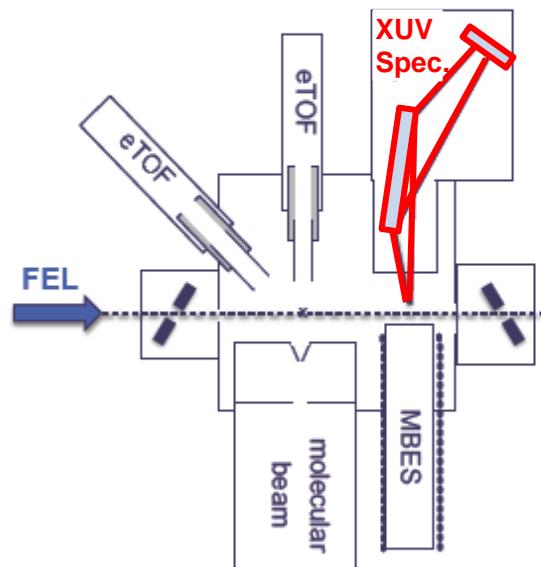


AQS - Chamber

(side view)



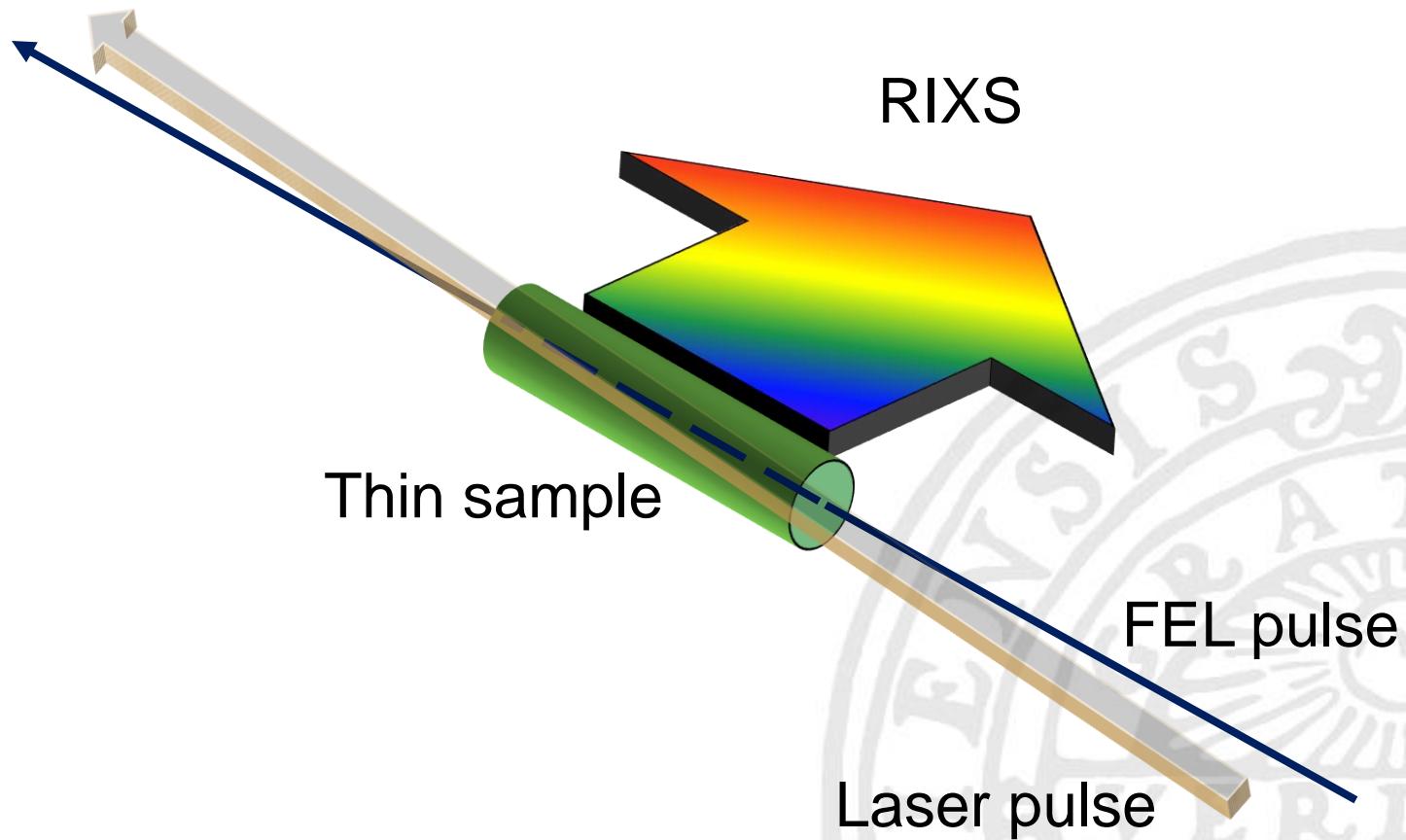
(top view)





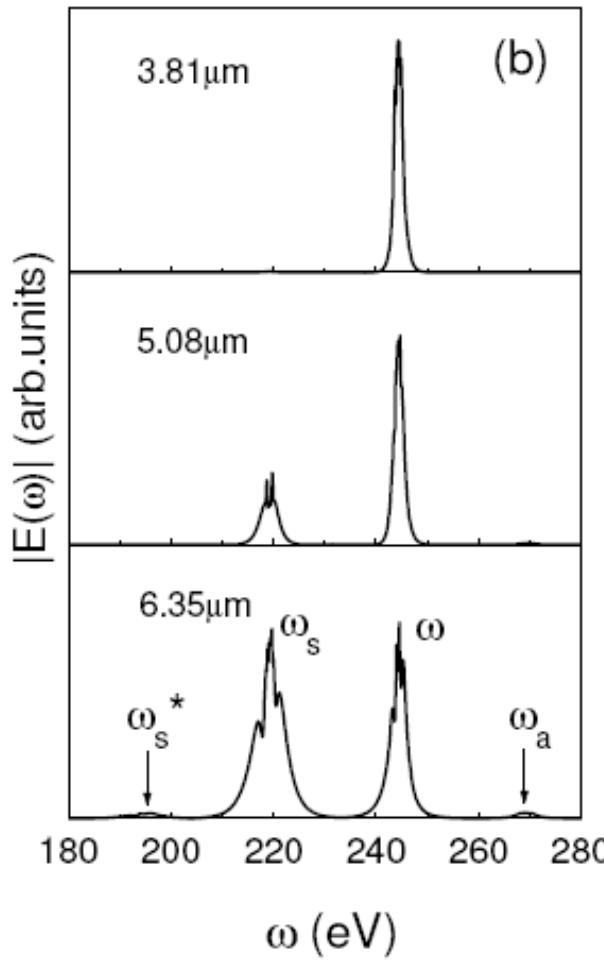
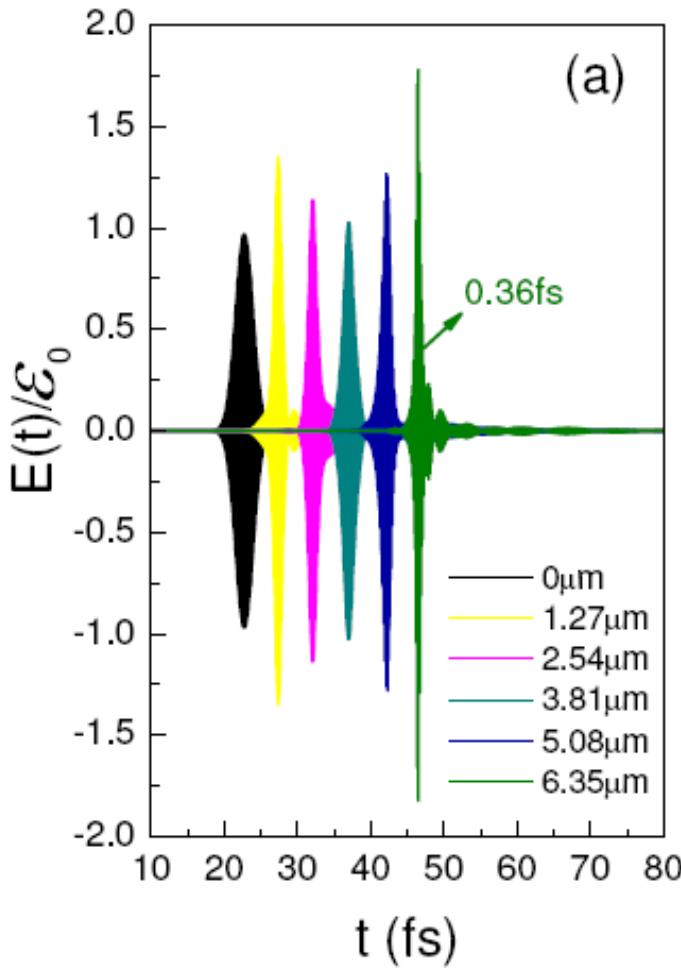
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Pump-probe experiments with RIXS





Non-linear processes in FEL beam interaction



4s-2p

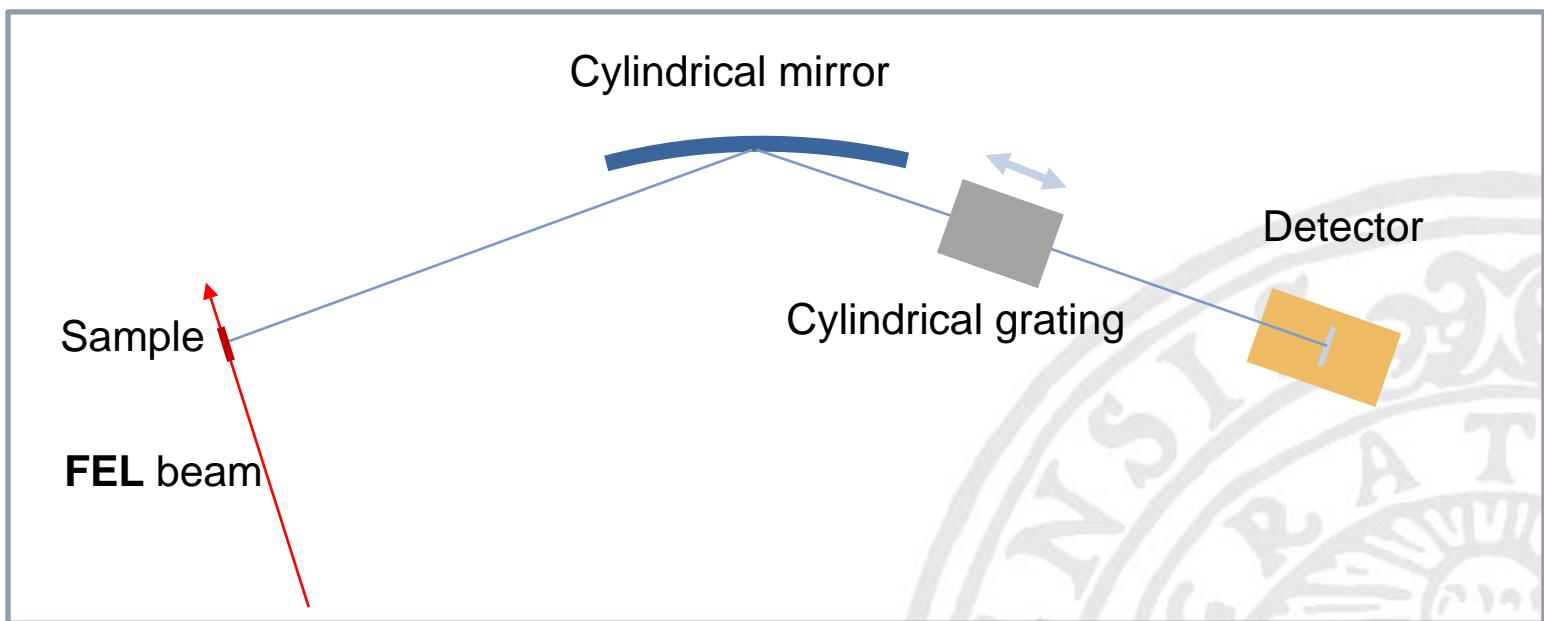
Spectral broadening
stimulates 3s-2p

4-wave mixing



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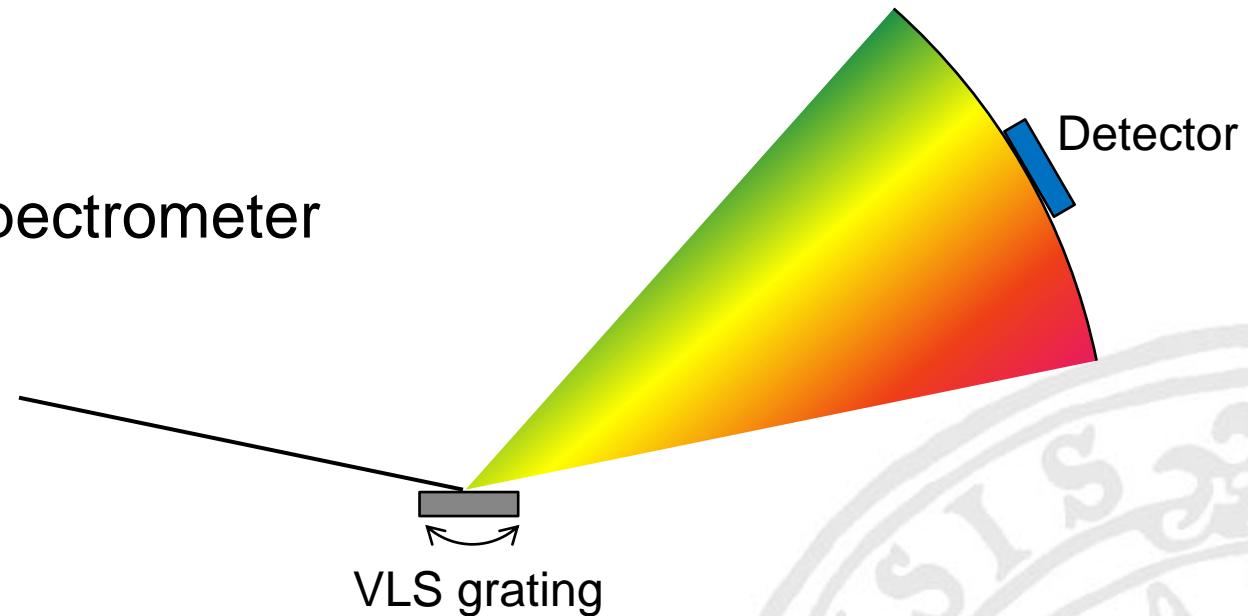
Cylindrical mirror imaging RIXS



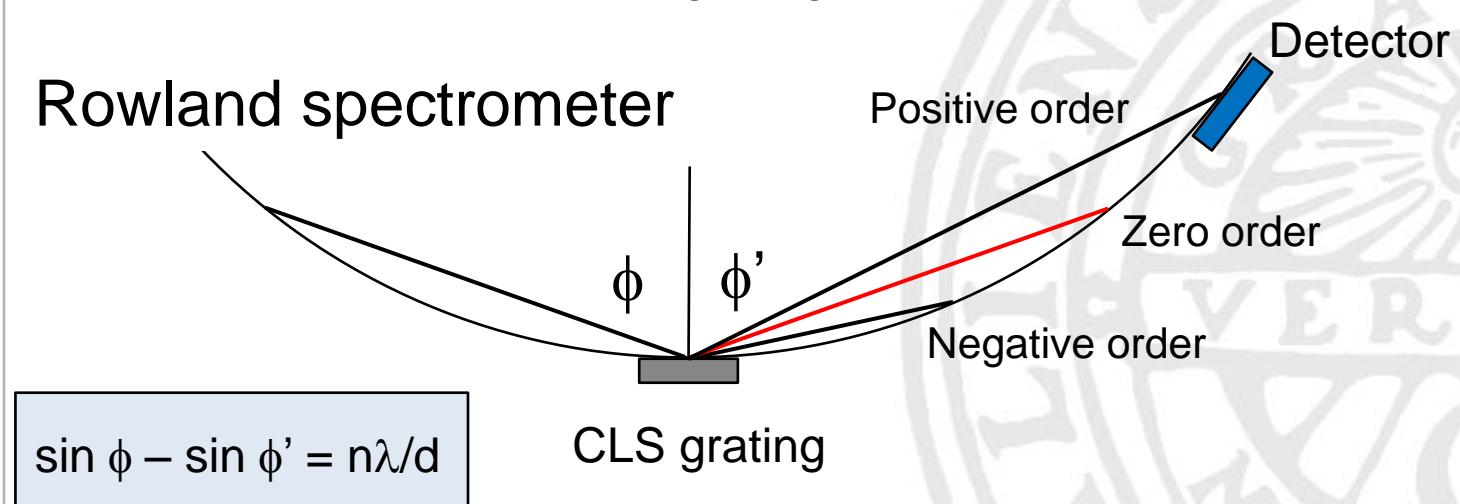


Soft X-ray grating spectrometers

VLS spectrometer



Rowland spectrometer





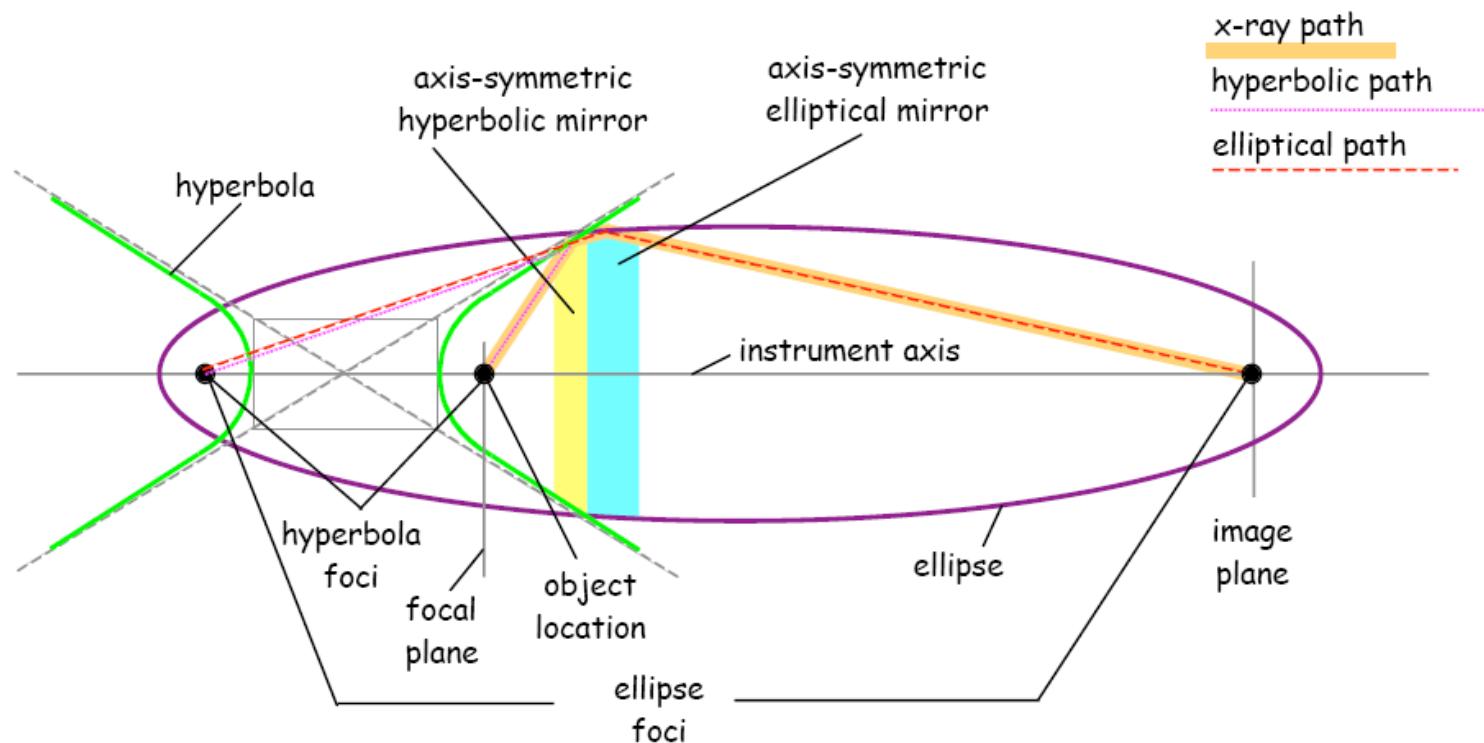
Spatial resolution for cylindrical mirror





Principle of Wolter Microscope

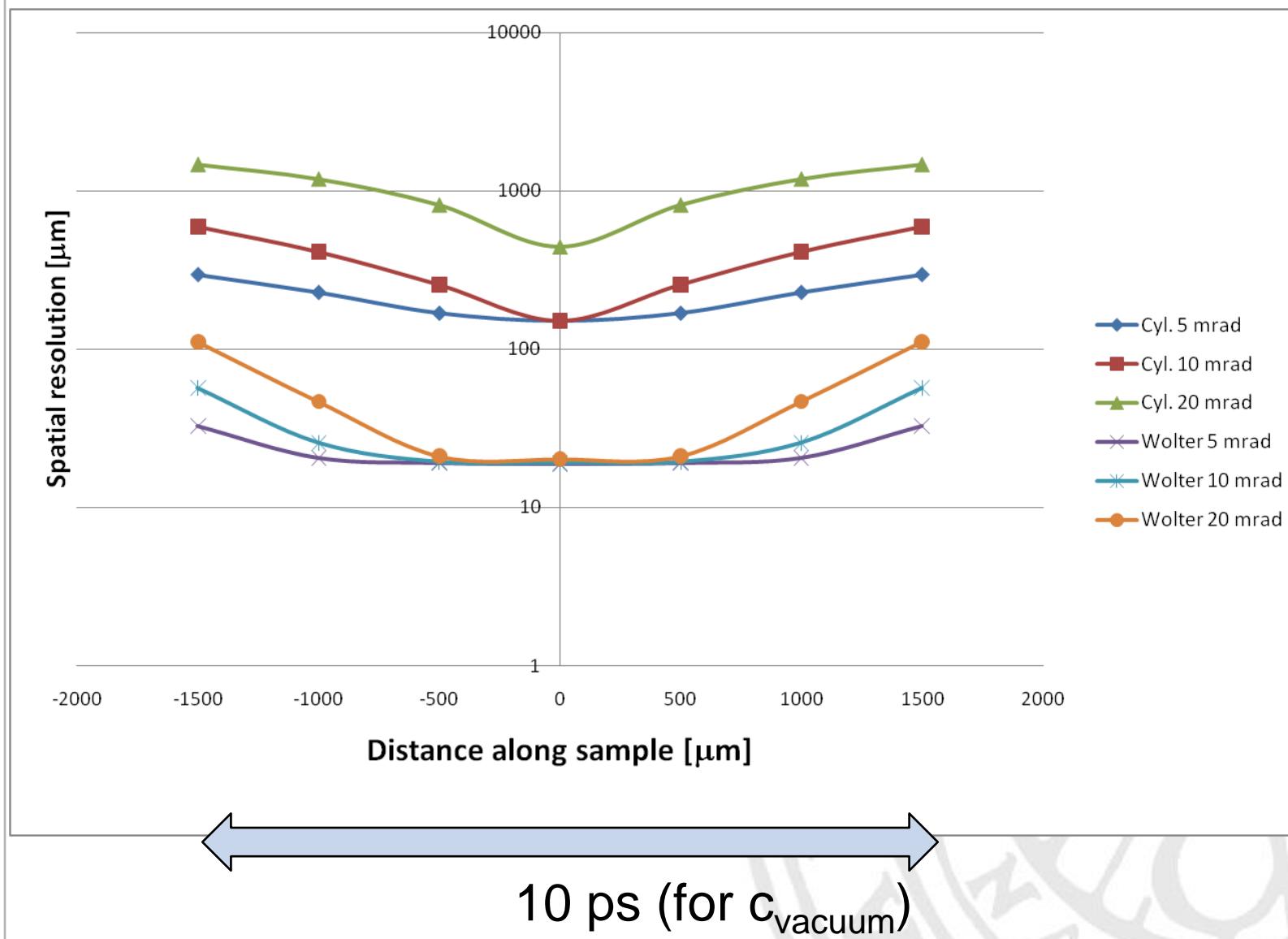
Wolter, H. 1952, Annalen der Physik (6. Folge) 10, 94



J.A. Jackson, LLNL report UCRL-TR-220019 (2006)

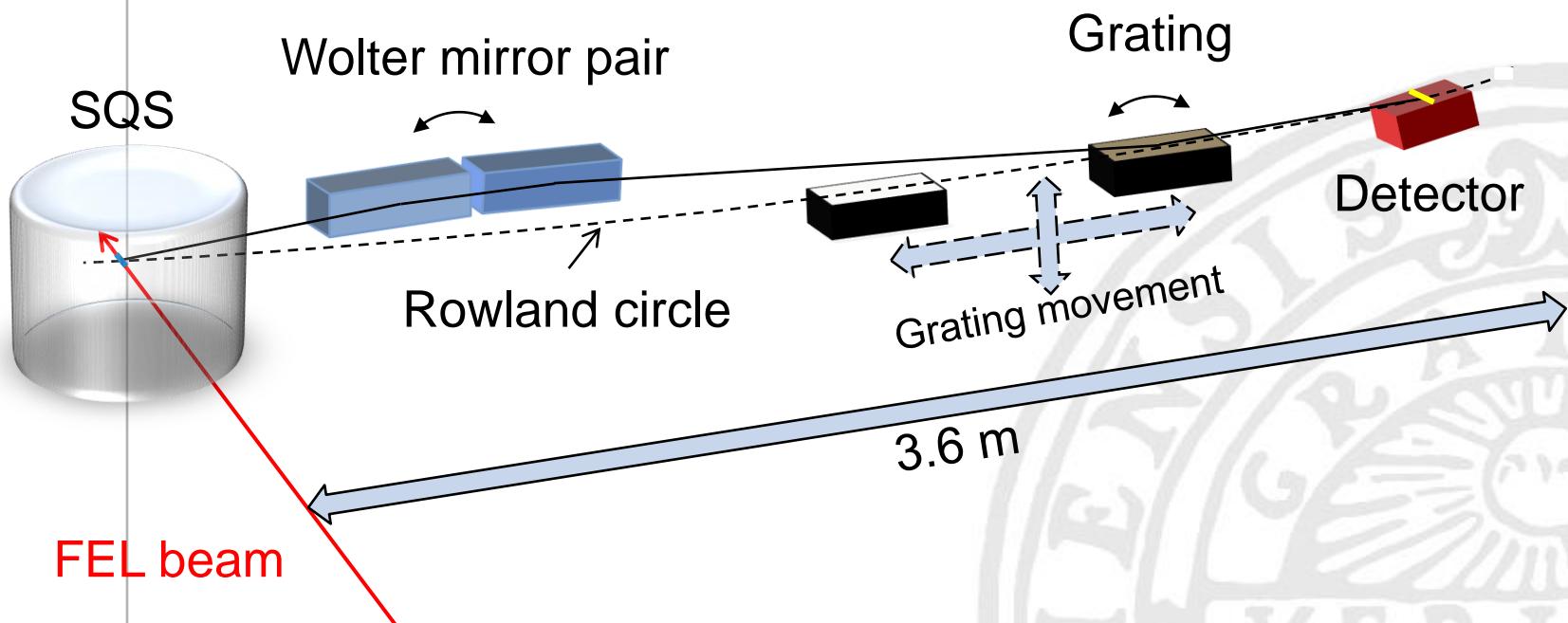


Comparison Cylindrical mirror – Wolter pair @ 150 μm detector resolution





Outline of 1-D Imaging RIXS Spectrometer





Imaging detectors for Soft X-rays

Issues:

Resolution - < 50 µm

Sensitivity at various incidence angles

Speed – 220 ns pulse separation

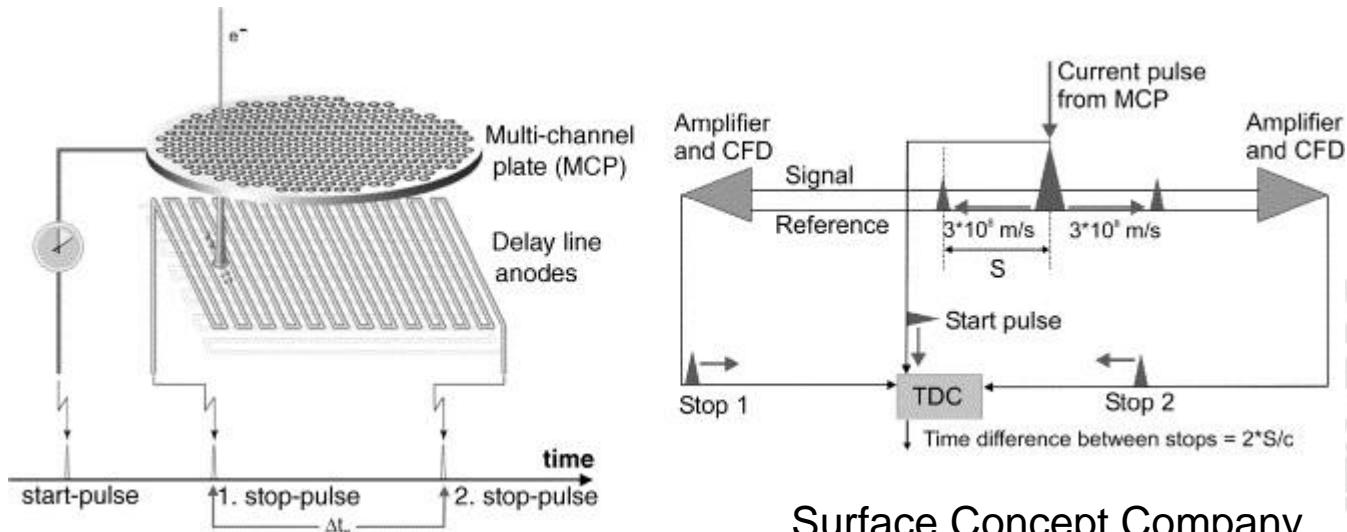
Back thinned CCD

MCP with various read-outs

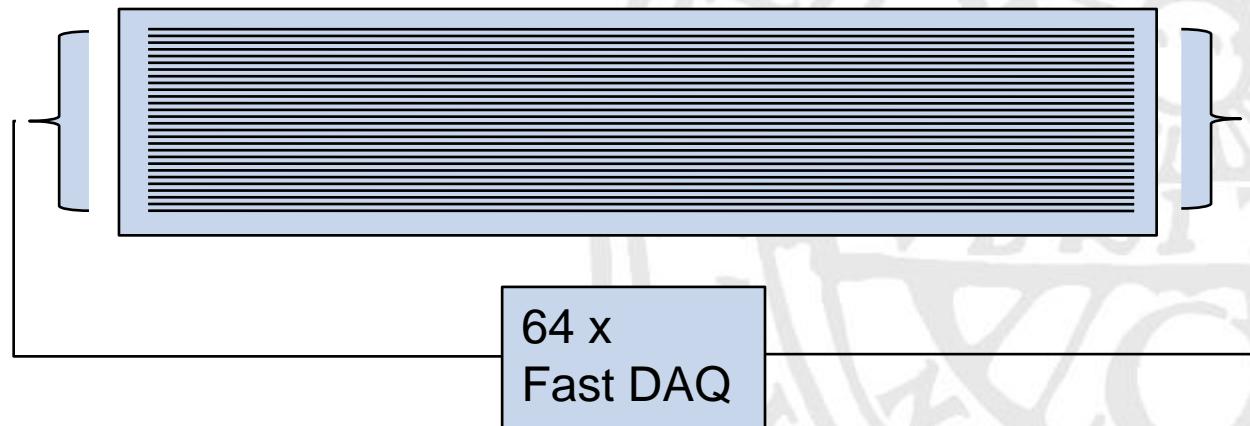
Pixelled silicon devices with on-board memory



Striped Time Delay Detector

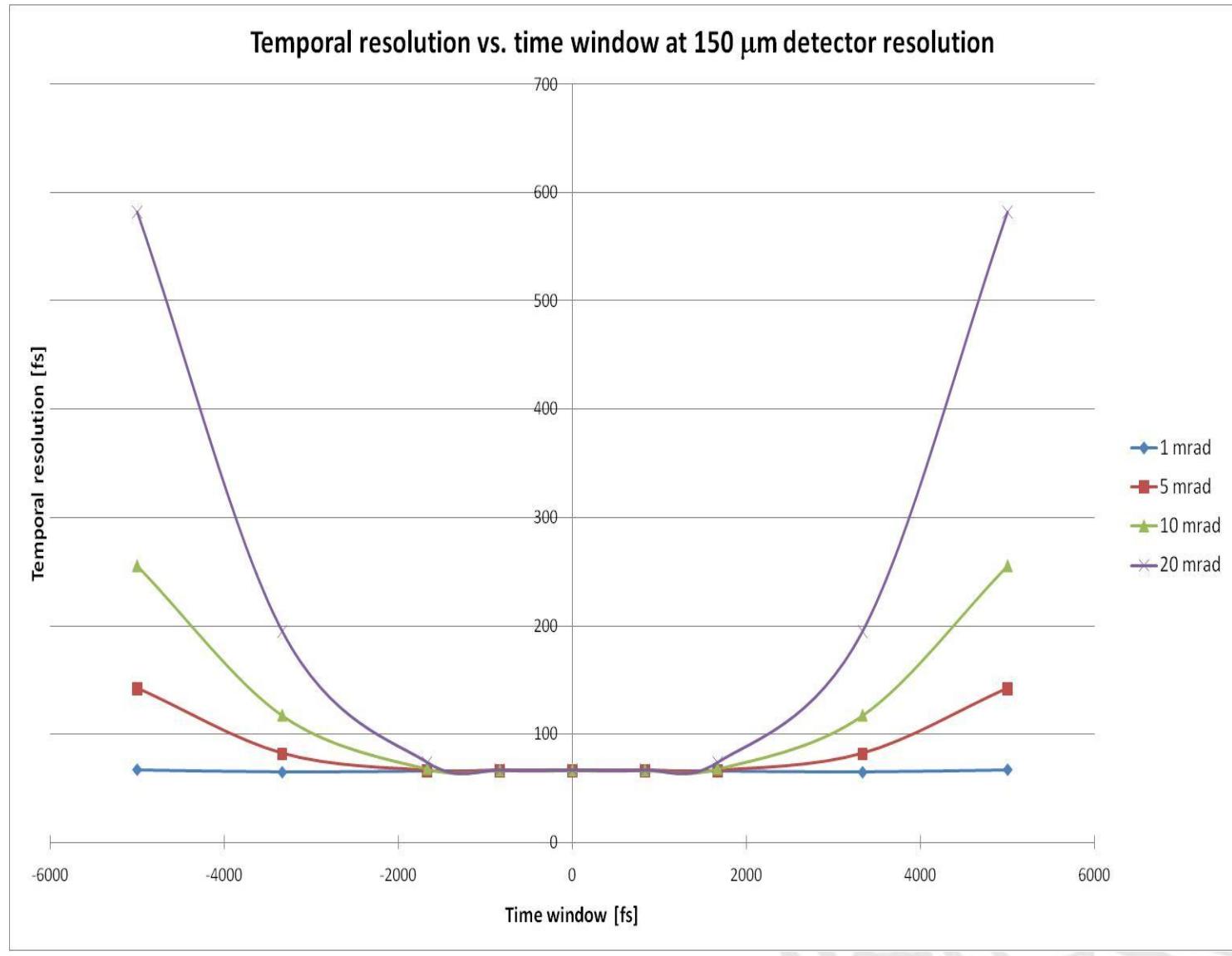


Surface Concept Company



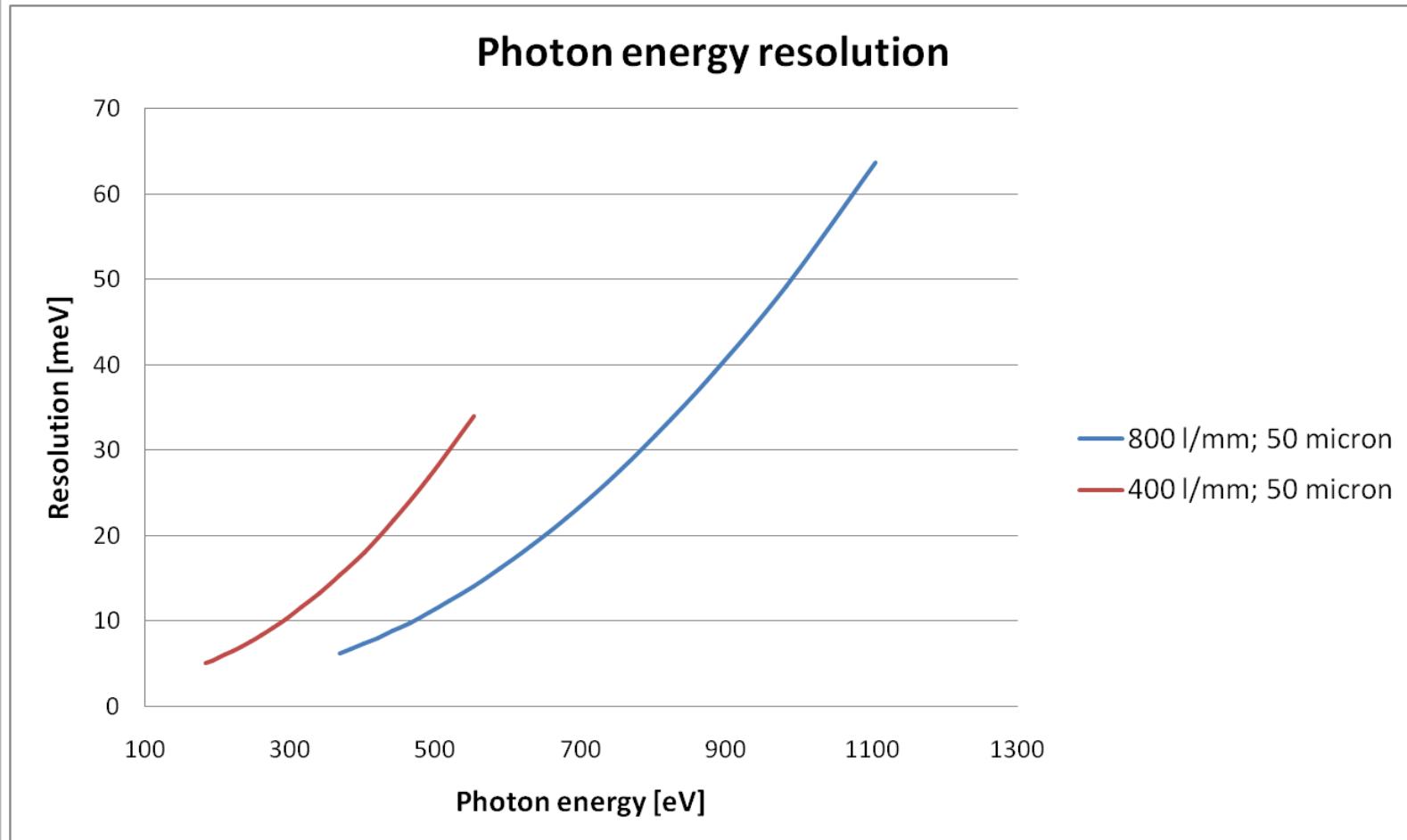


Temporal resolution - Wolter optics @ 150 μm detector resolution



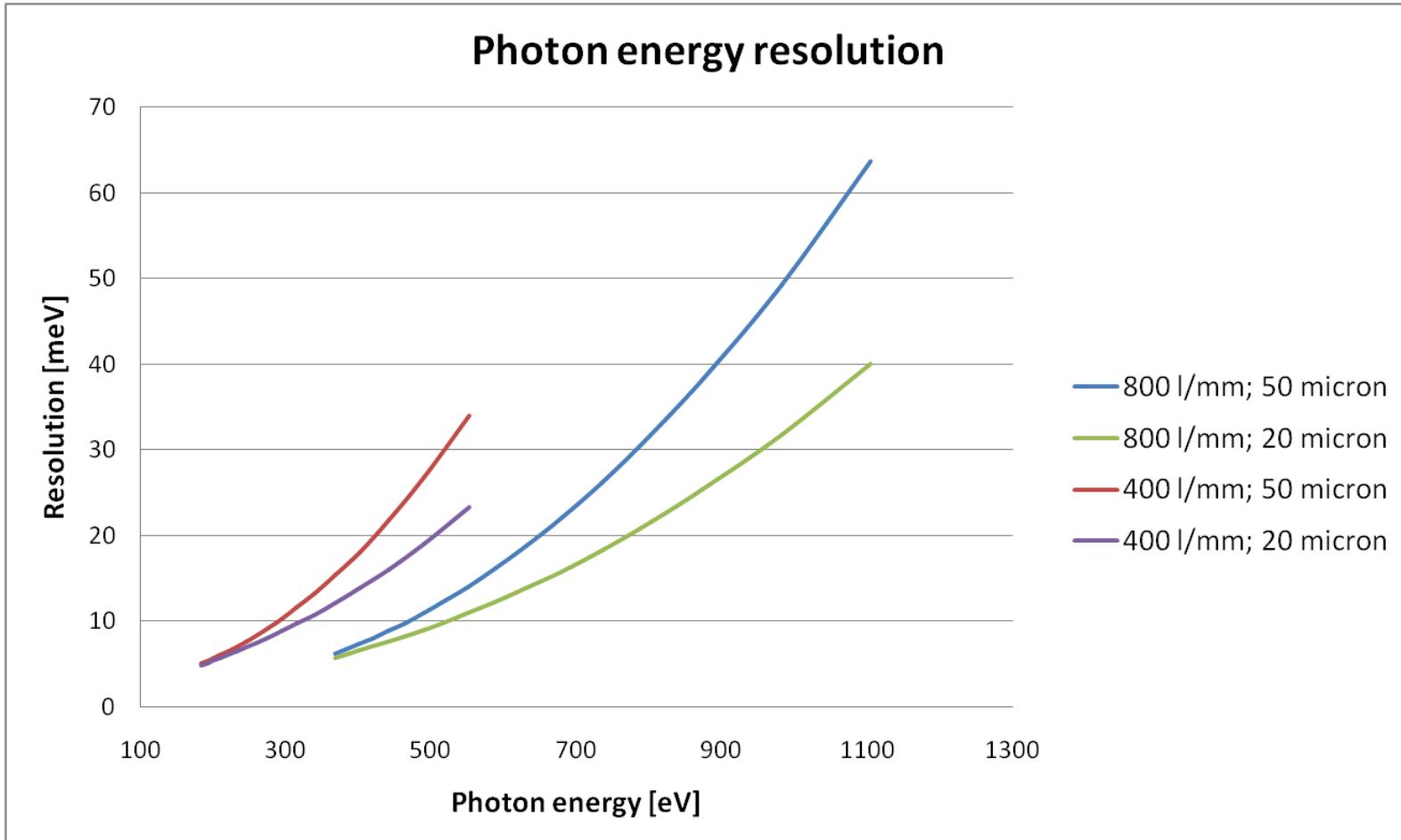


Photon Energy Resolution





Photon Energy Resolution





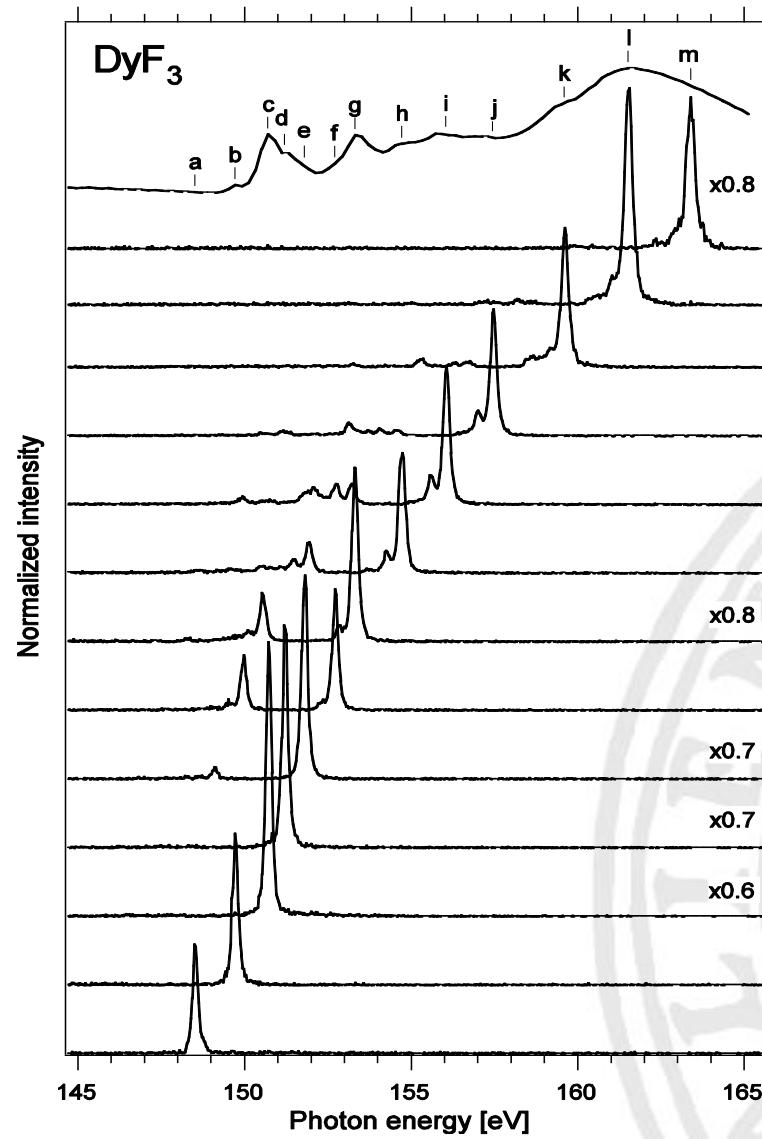
Other Applications of 1-D Imaging RIXS

- Spectroscopic imaging
 - Non-homogeneous samples
 - Graded sample composition
- RIXS maps



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RIXS Maps

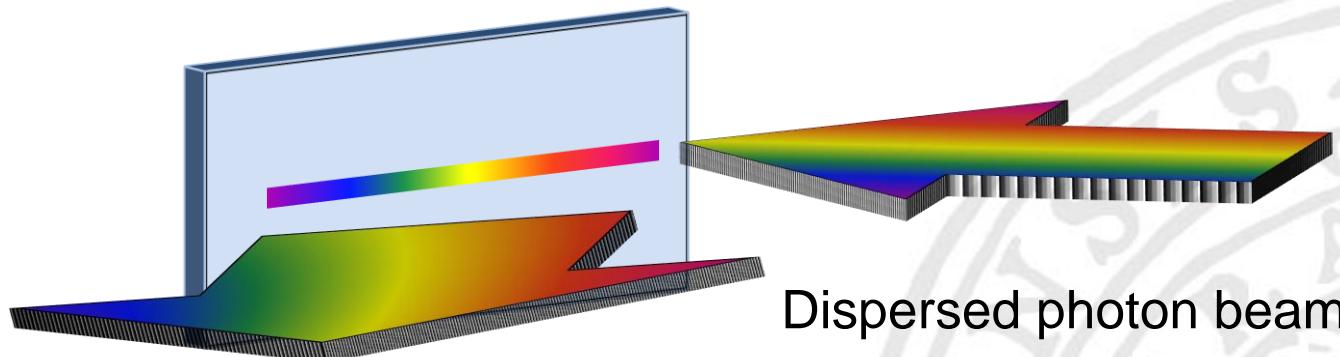




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RIXS Map Recording by 1-D Imaging Spectrometer

Homogeneous sample

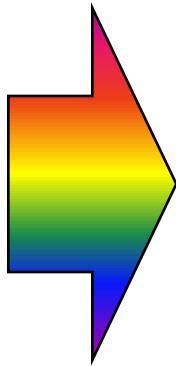


Position coded RIXS

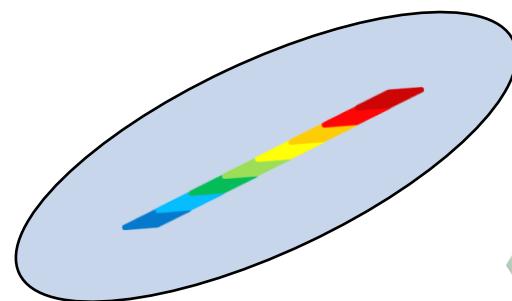


Vertical to horizontal dispersion

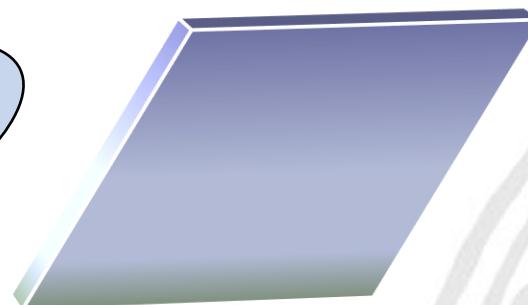
From mono



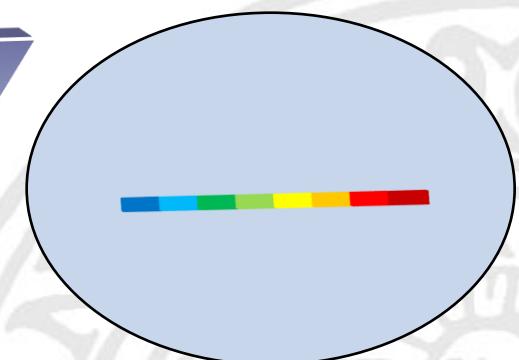
Vertical dispersion



Grazing inc. mirror
at ~45 deg. slant



Horizontal dispersion





Acknowledgement

- Marcus Agåker
- Jan-Erik Rubensson
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- Michael Meyer
- Monica Turcato
- Markus Kuster

